

30V N-Channel Trench MOSFET(Preliminary)

| - | | | Product Summary | |
|---|---|--|---|--|
| Trench Power technology Low P | | | V _{DS} | 30V |
| Low R_{DS(ON)} Low Gate Charge | | | I_D (at V_{GS} =10V) | 160A |
| High Current Capability | | | $R_{DS(ON)}$ (at V _{GS} =10V) $R_{DS(ON)}$ (at V _{GS} =4.5V) | < 1.8mΩ < 2.5mΩ |
| | | | $(\alpha_{\rm CS} - 4.5 \text{ V})$ | < 2.01112 |
| Applications | | | | |
| • Synchronous Rectification in | n DC/DC and AC | DC Converters | 100% UIS Tested | Pous |
| Isolated DC/DC Converters i | n Telecom and Ir | ndustrial | | Kons |
| C | PFN5x6 | S S G | G G S | |
| Part Number | Packa | де Туре | Form | Marking |
| TTG160N03AT | DF | N5x6 | Tape&Reel | 160N03AT |
| | | | | |
| Absolute Maximum Ra Parameter | tings (T _A =2 | 5ºC unless o | therwise noted) Maximum | Units |
| | tings (T _A =2 | 1 | | Units V |
| Parameter | tings (T _A =2 | Symbol | Maximum | |
| Parameter Drain-Source Voltage Gate-Source Voltage | tings (T _A =2 T _c =25°C | Symbol V _{DS} V _{GS} | Maximum 30 | V V |
| Parameter Drain-Source Voltage | 1 | Symbol V _{DS} | Maximum 30 ±20 | V |
| Parameter Drain-Source Voltage Gate-Source Voltage | T _c =25°C | Symbol V _{DS} V _{GS} | Maximum 30 ±20 160 | V V |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current | T _c =25°C | Symbol V _{DS} V _{GS} I _D | Maximum 30 ±20 160 110 | V V A |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current A Pulsed Drain Current | T _c =25°C | Symbol V _{DS} V _{GS} I _D I _{DM} | Maximum 30 ±20 160 110 480 | V V A A |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current A Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy | $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ | Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} | Maximum 30 ±20 160 110 480 56 | V V A A A A |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Avalanche Current | $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ L = 0.3mH ^A | Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} | Maximum 30 ±20 160 110 480 56 470 | V V A A A M J |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current A Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy | $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ | Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} | Maximum 30 ±20 160 110 480 56 470 136 | V V A A A M M W |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current A Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy Power Dissipation C | $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ | Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D | Maximum 30 ±20 160 110 480 56 470 136 68 | V V A A A M M W W |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Avalanche Drain Current Avalanche Current Asingle Pulse Avalanche Energy Power Dissipation C Junction and Storage Temperatu | $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ | Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D | Maximum 30 ±20 160 110 480 56 470 136 68 | V V A A A M M W W |
| Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Avalanche Current Avalanche Current Power Dissipation C Junction and Storage Temperatu Thermal Characteristics | $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ | Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D T _J , T _{STG} | Maximum 30 ±20 160 110 480 56 470 136 68 -55 to 175 | V V A A A M M W W W V V |



| Electric | cal Characteristics(T _J =25°C u | nless otherwise r | noted) | | | | |
|--|--|---|-----------------------|-------|------|------|-------|
| Cumphiel | Devemeter | rameter Conditions | | Value | | | |
| Symbol | Farameter | | | Min | Тур | Max | Units |
| STATIC P | ARAMETERS | | | | | - | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_{D} = 250 \mu A, V_{GS} = 0V$ | | 30 | | | V |
| I _{DSS} Zero Gate Voltage Drain Current | | T _J =25⁰C | | | 1 | | |
| | Zero Gate Voltage Drain Current | V _{DS} =30V, V _{GS} =0V | T _J =125°C | | | 100 | μA |
| I _{GSS} | Gate-Body Leakage Current | $V_{DS} = 0V, V_{GS} = \pm 20V$ | | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250µA | | 1 | 1.6 | 2.4 | V |
| | Statia Drain Source On Desistance | V _{GS} =10V, I _D =30A | | 1.3 | 1.8 | mΩ | |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =4.5V, I _D =30A | | 2.0 | 2.5 | mΩ | |
| 9 _{FS} | Forward Transconductance | V _{DS} =10V, I _D =20A | | | 61 | | S |
| V _{SD} | Diode Forward Voltage | I _S =30A, V _{GS} =0V | | | | 1 | V |
| ls | Maximum Body-Diode Continuous Curre | ent ^B | | | | 51 | А |
| DYNAMIC | PARAMETERS | | | _ | - | - | _ |
| C _{iss} | Input Capacitance | | | | 8826 | | |
| C _{oss} | Output Capacitance | V _{GS} =0V, V _{DS} =15V, f =1MH _Z | | | 1320 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | | 1386 | | |
| R _g | Gate Resistance | f =1MH _z | | | 1.7 | | Ω |
| SWITCHI | NG PARAMETERS | | | | | | |
| Q _g | Total Gate Charge | V _{GS} =10V,V _{DS} =15V, I _D =50A | | | 177 | | |
| Q _{gs} | Gate Source Charge | | | | 29 | | nC |
| Q_{gd} | Gate Drain Charge | | | | 35 | | |
| t _{D(on)} | Turn-On Delay Time | V _{GS} =10V,V _{DS} =15V, I _D =50A, | | | 30 | | |
| t _r | Turn-On Rise Time | | | | 29 | | |
| T _{D(off)} | Turn-Off Delay Time | $R_{G} = 3\Omega$ | | | 101 | | ns |
| t _f | Turn-Off Fall Time | 1 | | | 48 | | |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =30A, di/dt =100A/µ | | | 47 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | $\mu_{\rm F} = 30 \text{Å}, \ \text{u/ut} = 100 \text{Å/}\mu$ | 15 | | 43 | | nC |

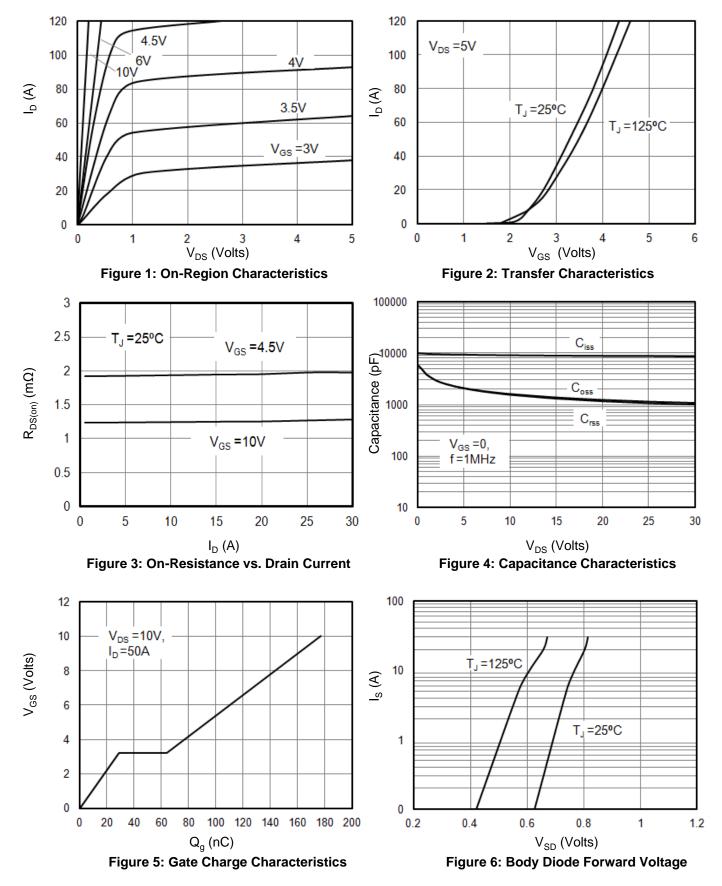
A. Single pulse width limited by maximum junction temperature.

B. The maximum current rating is package limited.

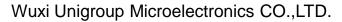
C. The power dissipation P_D is based on $T_{J(MAX)} = 175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



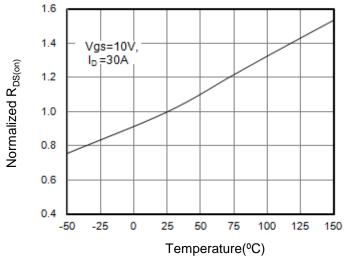
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

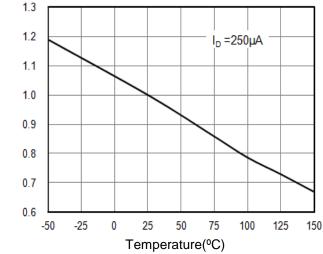


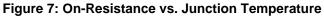


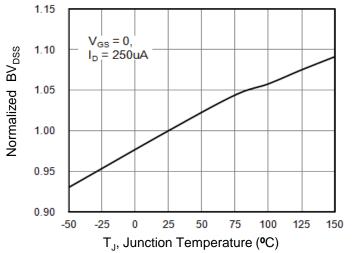


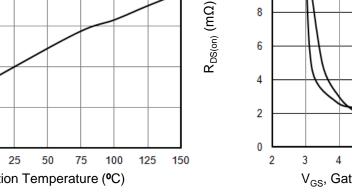
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS











Normalized Vgs(th)

Figure 9: BV_{DSS} vs. Junction Temperature Figure 10: On-Resistance vs. Gate-Source Voltage

D =0.5

D =0.2

D =0.1

D =0.05

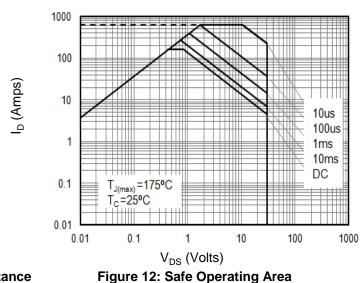
D =0.02

D =0.01

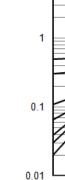
Single Pulse

1

0.1



 $Z_{\,\Theta\,JC}$ Normalized Transient Thermal Resistance

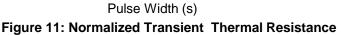


0.00001

0.0001

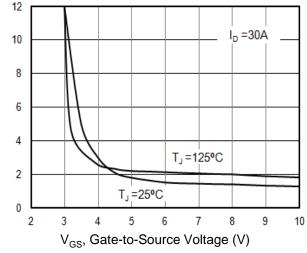
0.001

10

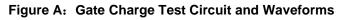


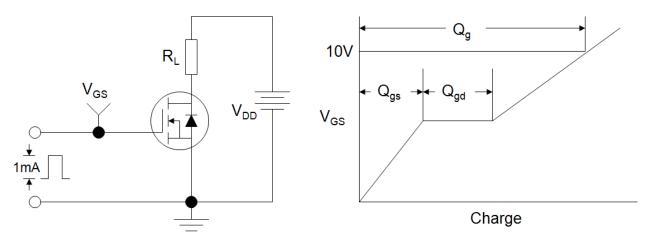
0.01

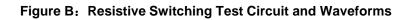




10







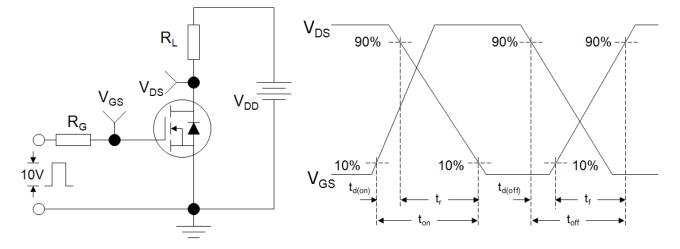
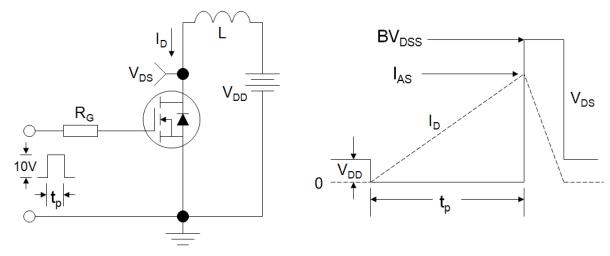
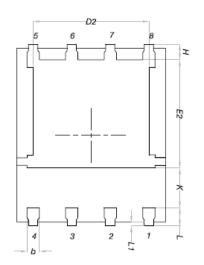
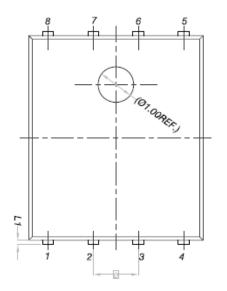
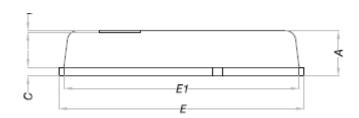


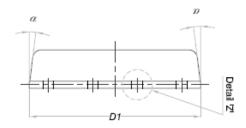
Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms









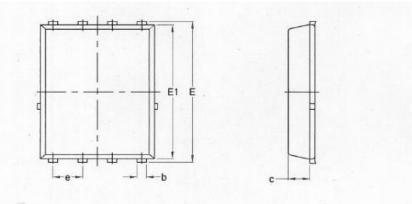


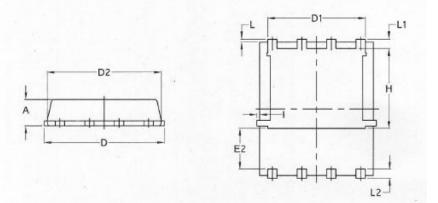
| | N | 1ILLIMET | ERS | | N | IILLIMET | ERS |
|------|------|----------|------|------|------|----------|------|
| DIM. | MIN. | NOM. | MAX. | DIM. | MIN. | NOM. | MAX. |
| А | 0.90 | 1.00 | 1.10 | E | 5.90 | 6.00 | 6.10 |
| A1 | 0 | - | 0.05 | E1 | 5.70 | 5.75 | 5.80 |
| b | 0.33 | 0.41 | 0.51 | E2 | 3.38 | 3.58 | 3.78 |
| С | 0.20 | 0.25 | 0.30 | е | | 1.27 BSC | |
| D1 | 4.80 | 4.90 | 5.00 | Н | 0.41 | 0.51 | 0.61 |
| D2 | 3.61 | 3.81 | 3.96 | К | 1.10 | - | - |
| | | | | L | 0.51 | 0.61 | 0.71 |
| | | | | L1 | 0.06 | 0.13 | 0.20 |
| | | | | α | 0° | - | 12° |

DFN5x6(M)









| 1 | S Y | COMMON | | | | | |
|---|-------------|----------|-------|----------|--------|--|--|
| | M B O | M | M | INCH | | | |
| | ĉ | MIN. | MAX. | MIN. | MAX. | | |
| | А | 1.03 | 1.17 | 0.0406 | 0.0461 | | |
| | b | 0.34 | 0.48 | 0.0134 | 0.0189 | | |
| | с | 0.824 | 0.970 | 0.0324 | 0.0382 | | |
| 7 | D | 4.80 | 5.40 | 0.1890 | 0.2126 | | |
| | D1 | 4.11 | 4.31 | 0.1618 | 0.1697 | | |
| 1 | D2 | 4.80 | 5.00 | 0.1890 | 0.1969 | | |
| | E | 5.95 | 6.15 | 0.2343 | 0.2421 | | |
| | E1 | 5.65 | 5.85 | 0.2224 | 0.2303 | | |
| | E2 | 1.60 | - | 0.0630 | | | |
| e | | 1.27 BSC | | 0.05 BSC | | | |
| 1 | L | 0.05 | 0.25 | 0.0020 | 0.0098 | | |
| | L1 | 0.38 | 0.50 | 0.0150 | 0.0197 | | |
| | L2 | 0.38 | 0.50 | 0.0150 | 0.0197 | | |
| 4 | н | 3.30 | 3.50 | 0.1299 | 0.1378 | | |
| | 1 | _ | 0.18 | _ | 0.0070 | | |



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